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Quarterly Reliability Monitoring Results

Quarters: Q1/2021 to Q4/2021

Based on structural similarity

Supplier Nexperia B.V. Name of Laboratory Assembly reliability labs		User Part Number						
		IP4294CZ10-TBR Part Description						
								NXP ICN8 Protection INDI
		MCD package						
		Test		Test Conditions	Duration	# Lots	# Quantity	# Rejects
	TEST							
	Pre- and Post-Stress							
# 1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below		
	PC	JESD22-A113 Bake Tamb = 125 °C	24 hours					
# 2	Preconditioning	Soak Tamb = 85 °C, RH = 85% Reflow soldering	168 hours 3 cycles	142	11435	0		
	HTRB High Temperature Reverse	MIL-STD-750-1 M1038 Method A Tj = Tjmax, Vr = 100% of max. datasheet						
# 5	Bias	reverse voltage	1000 hours	18	1440	0		
	тс	JESD22-A104						
# 7	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	53	4225	0		
	AC	JESD22-A102 Tamb = 121 °C, RH = 100 %						
# 8	Autoclave	Pressure = $205 \text{ kPa} (29.7 \text{ psia})$	96 hours	39	3165	0		
	H3TRB High Humidity High	JESD22-A101 Tamb = 85 °C, RH = 85%, VR = 80 % of						
# 9	Temperature Reverse Bias		1000 hours	51	4045	0		
	IOL	MIL-STD-750 Method 1037 ton = toff, devices powered to insure ΔTj =						
# 10	Intermittent Operating Life	100 °C for 15000 cycles	1000 hours	n.a.	n.a.	n.a.		
	RSH	JESD22-A111						
# 20	Resistance to Solder Heat		10 s	n.a.	n.a.	n.a.		
# 21	SD Solderability	J-STD-002		78	780	0		

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

NXP ICN8 Protection INDI 1440 0 2.95 3.39E+08	Wafer Fab	Technology	Quantity	Rejects	Failure Rate (FIT)	MTTF (hrs)
	NXP ICN8	Protection INDI	1440	0	2.95	3.39E+08

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